

## **Amendments to the Claims**

1. (Currently Amended) An atomic layer deposition method of depositing an oxide on a substrate comprising:

~~positioning~~ providing a substrate within a deposition chamber;

chemisorbing a first species to form a first species monolayer onto the substrate within the deposition chamber from a gaseous precursor;

contacting the chemisorbed first species with remote plasma oxygen derived at least in part from at least one of  $O_2$  and  $O_3$  and with remote plasma nitrogen effective to react with the first species to form a monolayer comprising an oxide of a component of the first species monolayer; and

successively repeating the chemisorbing and the contacting with remote plasma oxygen and with remote plasma nitrogen effective to form porous oxide on the substrate.

2. (Original): The method of claim 1 wherein the porous oxide comprises electrically insulative oxide.

3. (Original): The method of claim 2 wherein the porous oxide comprises  $SiO_2$ .

4. (Original): The method of claim 2 wherein the porous oxide comprises  $Al_2O_3$ .

5. (Original): The method of claim 1 wherein the porous oxide comprises electrically conductive oxide.

6. (Original): The method of claim 5 wherein the porous oxide comprises tin oxide.

7. (Original): The method of claim 5 wherein the porous oxide comprises indium oxide.

8. (Original): The method of claim 5 wherein the porous oxide comprises  $\text{In}_x\text{Sn}_y\text{O}$ .

9. (Currently Amended) ~~The method of claim 8 wherein~~ An atomic layer deposition method of depositing an oxide on a substrate comprising:

providing a substrate within a deposition chamber;

chemisorbing a first species to form a first species monolayer onto the substrate within the deposition chamber from a gaseous precursor;

contacting the chemisorbed first species with remote plasma oxygen derived at least in part from at least one of O<sub>2</sub> and O<sub>3</sub> and with remote plasma nitrogen effective to react with the first species to form a monolayer comprising an oxide of a component of the first species monolayer; and

successively repeating the chemisorbing and the contacting with remote plasma oxygen and with remote plasma nitrogen effective to form porous electrically conductive oxide comprising In<sub>x</sub>Sn<sub>y</sub>O<sub>z</sub> on the substrate,  
the gaseous precursor comprises comprising an indium-containing indium-containing precursor and a tin-containing tin-containing precursor  
which are fed to the deposition chamber simultaneously.

10. (Currently Amended) ~~The method of claim 8 wherein~~ An atomic layer deposition method of depositing an oxide on a substrate comprising:

providing a substrate within a deposition chamber;

chemisorbing a first species to form a first species monolayer onto the substrate within the deposition chamber from a gaseous precursor;

contacting the chemisorbed first species with remote plasma oxygen derived at least in part from at least one of O<sub>2</sub> and O<sub>3</sub> and with remote plasma nitrogen effective to react with the first species to form a monolayer comprising an oxide of a component of the first species monolayer; and

successively repeating the chemisorbing and the contacting with remote plasma oxygen and with remote plasma nitrogen effective to form porous electrically conductive oxide comprising In<sub>x</sub>Sn<sub>y</sub>O<sub>z</sub> on the substrate,  
the gaseous precursor ~~comprises~~ comprising an indium-containing ~~indium-containing~~ precursor and a tin-containing ~~tin-containing~~ precursor which are fed to the deposition chamber at different times.

11. (Original): The method of claim 10 wherein the different times overlap one another.

12. (Original): The method of claim 10 wherein the different times are spaced from one another.

13. (Original): The method of claim 1 wherein the porous oxide comprises multiple different cations.

14. (Original): The method of claim 1 wherein the gaseous precursor comprises trimethyl aluminum, the component comprises aluminum, and the porous oxide comprises  $\text{Al}_2\text{O}_3$ .

15. (Original): The method of claim 1 wherein the gaseous precursor comprises at least one of TEOS and a silane, the component comprises silicon, and the porous oxide comprises  $\text{SiO}_2$ .

16. (Original): The method of claim 15 wherein the gaseous precursor comprises TEOS.

17. (Original): The method of claim 15 wherein the gaseous precursor comprises a silane.

18. (Original): The method of claim 1 wherein the gaseous precursor comprises trimethyl tin, the component comprises tin, and the porous oxide comprises tin oxide.

19. (Original): The method of claim 1 wherein the gaseous precursor comprises trimethyl indium, the component comprises indium, and the porous oxide comprises indium oxide.

20. (Original): The method of claim 1 wherein the gaseous precursor comprises trimethyl tin, the gaseous precursor comprises trimethyl indium, and the porous oxide comprises  $\text{In}_x\text{Sn}_y\text{O}$ .

21. (Original): The method of claim 1 wherein the remote plasma nitrogen is derived at least in part from  $\text{N}_2$ .

22. (Original): The method of claim 21 wherein nitrogen of the remote plasma nitrogen is derived entirely from  $\text{N}_2$ .

23. (Original): The method of claim 1 wherein the remote plasma nitrogen is derived at least in part from  $\text{N}_2\text{O}$ .

24. (Original): The method of claim 23 wherein nitrogen of the remote plasma nitrogen is derived entirely from  $\text{N}_2\text{O}$ .

25. (Original): The method of claim 1 wherein the remote plasma nitrogen is derived at least in part from  $\text{NO}_x$ .

26. (Currently Amended): The method of claim 25 wherein nitrogen of the remote plasma nitrogen is derived entirely from  $\text{N}_2$  or  $\text{NO}_x$ .

27. (Original): The method of claim 1 wherein the remote plasma oxygen is derived at least in part from  $\text{O}_2$ .

28. (Original): The method of claim 1 wherein oxygen of the remote plasma oxygen is derived entirely from O<sub>2</sub>.

29. (Original): The method of claim 1 wherein the remote plasma oxygen is derived at least in part from O<sub>3</sub>.

30. (Original): The method of claim 1 wherein the remote plasma oxygen and the remote plasma nitrogen are fed as a mixture to the deposition chamber.

31. (Original): The method of claim 1 wherein the remote plasma oxygen and the remote plasma nitrogen are fed separately to the deposition chamber.

32. (Original): The method of claim 31 wherein the remote plasma oxygen and the remote plasma nitrogen are fed separately to the deposition chamber at different times.

33. (Original): The method of claim 32 wherein the different times are spaced from one another.

34. (Original): The method of claim 32 wherein the different times overlap one another.

35. (Currently Amended): ~~The method of claim 31 wherein~~ An atomic layer deposition method of depositing an oxide on a substrate comprising:

providing a substrate within a deposition chamber;

chemisorbing a first species to form a first species monolayer onto the substrate within the deposition chamber from a gaseous precursor;

contacting the chemisorbed first species with remote plasma oxygen derived at least in part from at least one of O<sub>2</sub> and O<sub>3</sub> and with remote plasma nitrogen effective to react with the first species to form a monolayer comprising an oxide of a component of the first species monolayer, the remote plasma oxygen and the remote plasma nitrogen are being fed separately to the deposition chamber simultaneously; and

successively repeating the chemisorbing and the contacting with remote plasma oxygen and with remote plasma nitrogen effective to form porous oxide on the substrate.

36. (Original): The method of claim 1 wherein the remote plasma oxygen and the remote plasma nitrogen are generated in the same remote plasma generating chamber, and fed as a mixture to the deposition chamber.



37. (Currently Amended): ~~The method of claim 1 wherein~~ An atomic layer deposition method of depositing an oxide on a substrate comprising:

providing a substrate within a deposition chamber;  
chemisorbing a first species to form a first species monolayer onto the substrate within the deposition chamber from a gaseous precursor;  
contacting the chemisorbed first species with remote plasma oxygen derived at least in part from at least one of O<sub>2</sub> and O<sub>3</sub> and with remote plasma nitrogen effective to react with the first species to form a monolayer comprising an oxide of a component of the first species monolayer, the remote plasma oxygen and the remote plasma nitrogen are being generated in different remote plasma generating chambers; and  
successively repeating the chemisorbing and the contacting with remote plasma oxygen and with remote plasma nitrogen effective to form porous oxide on the substrate.

38. (Original): The method of claim 37 wherein the remote plasma oxygen and the remote plasma nitrogen are fed as a mixture to the deposition chamber.

39. (Original): The method of claim 1 wherein the remote plasma oxygen and the remote plasma nitrogen are fed to the deposition chamber simultaneously.

40. (Original): The method of claim 39 wherein the remote plasma nitrogen is from 0.01% to 90% by volume of all remote plasma oxygen and remote plasma nitrogen fed to the deposition chamber.

41. (Original): The method of claim 40 wherein the remote plasma nitrogen is from 0.1% to 10% by volume of all remote plasma oxygen and remote plasma nitrogen fed to the deposition chamber.

42. (Original): The method of claim 41 wherein the remote plasma nitrogen is from 0.1% to 3% by volume of all remote plasma oxygen and remote plasma nitrogen fed to the deposition chamber.

43. (Original): The method of claim 41 wherein the remote plasma nitrogen is from 0.01% to 1% by volume of all remote plasma oxygen and remote plasma nitrogen fed to the deposition chamber.

44. (Currently Amended): An atomic layer deposition method of depositing an oxide on a substrate comprising:

positioning providing a substrate within a deposition chamber;

chemisorbing a first species to form a first species monolayer onto the substrate within the deposition chamber from a gaseous precursor;

feeding a) at least one of  $O_2$  and  $O_3$ , and b) nitrogen to a remote plasma generator and forming a mixture of remote plasma oxygen and remote plasma nitrogen therefrom, the mixture comprising the remote plasma nitrogen at from 0.1% to 10% by volume of all remote plasma oxygen and remote plasma nitrogen generated by the generator;

feeding the remote plasma mixture to the deposition chamber and to contact the chemisorbed first species effective to react with the first species to form a monolayer comprising an oxide of a component of the first species monolayer; and

successively repeating the chemisorbing and the contacting with remote plasma oxygen and with remote plasma nitrogen effective to form porous oxide on the substrate.

45. (Original): The method of claim 44 wherein the porous oxide comprises electrically insulative oxide.

46. (Original): The method of claim 45 wherein the porous oxide comprises  $SiO_2$ .

47. (Original): The method of claim 45 wherein the porous oxide comprises  $\text{Al}_2\text{O}_3$ .

48. (Original): The method of claim 44 wherein the porous oxide comprises electrically conductive oxide.

49. (Original): The method of claim 48 wherein the porous oxide comprises tin oxide.

50. (Original): The method of claim 48 wherein the porous oxide comprises indium oxide.

51. (Original): The method of claim 48 wherein the porous oxide comprises  $\text{In}_x\text{Sn}_y\text{O}$ .

52. (Currently Amended): ~~The method of claim 51 wherein~~ An atomic layer deposition method of depositing an oxide on a substrate comprising:

~~positioning~~ providing a substrate within a deposition chamber;

chemisorbing a first species to form a first species monolayer onto the substrate within the deposition chamber from a gaseous precursor;

feeding a) at least one of O<sub>2</sub> and O<sub>3</sub>, and b) nitrogen to a remote plasma generator and forming a mixture of remote plasma oxygen and remote plasma nitrogen therefrom, the mixture comprising the remote plasma nitrogen at from 0.1% to 10% by volume of all remote plasma oxygen and remote plasma nitrogen generated by the generator;

feeding the remote plasma mixture to the deposition chamber and to contact the chemisorbed first species effective to react with the first species to form a monolayer comprising an oxide of a component of the first species monolayer; and

successively repeating the chemisorbing and the contacting with remote plasma oxygen and with remote plasma nitrogen effective to form porous oxide on the substrate, the gaseous precursor comprises comprising an indium-containing indium-containing precursor and a tin-containing tin-containing precursor which are fed to the deposition chamber simultaneously.

53. (Original): ~~The method of claim 51 wherein~~ An atomic layer deposition method of depositing an oxide on a substrate comprising:  
positioning providing a substrate within a deposition chamber;  
chemisorbing a first species to form a first species monolayer onto the substrate within the deposition chamber from a gaseous precursor;  
feeding a) at least one of O<sub>2</sub> and O<sub>3</sub>, and b) nitrogen to a remote plasma generator and forming a mixture of remote plasma oxygen and remote plasma nitrogen therefrom, the mixture comprising the remote plasma nitrogen at from 0.1% to 10% by volume of all remote plasma oxygen and remote plasma nitrogen generated by the generator;  
feeding the remote plasma mixture to the deposition chamber and to contact the chemisorbed first species effective to react with the first species to form a monolayer comprising an oxide of a component of the first species monolayer; and  
successively repeating the chemisorbing and the contacting with remote plasma oxygen and with remote plasma nitrogen effective to form porous oxide on the substrate, the gaseous precursor comprises comprising an indium-containing indium-containing precursor and a tin-containing tin-containing precursor which are fed to the deposition chamber at different times.

54. (Original): The method of claim 52 wherein the different times overlap one another.

55. (Original): The method of claim 52 wherein the different times are spaced from one another.

56. (Original): The method of claim 44 wherein the porous oxide comprises multiple different cations.

57. (Original): The method of claim 44 wherein the remote plasma mixture comprises the remote plasma nitrogen at from 0.1% to 3% by volume of all remote plasma oxygen and remote plasma nitrogen fed to the deposition chamber.

58. (Original): The method of claim 44 wherein the remote plasma mixture comprises the remote plasma nitrogen at from 0.01% to 1% by volume of all remote plasma oxygen and remote plasma nitrogen fed to the deposition chamber.

59. (Original): The method of claim 44 wherein the remote plasma nitrogen is derived at least in part from  $N_2$ .

60. (Original): The method of claim 59 wherein nitrogen of the remote plasma nitrogen is derived entirely from  $N_2$ .

61. (Original): The method of claim 44 wherein the remote plasma nitrogen is derived at least in part from  $N_2O$ .

62. (Original): The method of claim 61 wherein nitrogen of the remote plasma nitrogen is derived entirely from  $\text{N}_2\text{O}$ .

63. (Original): The method of claim 44 wherein the remote plasma nitrogen is derived at least in part from  $\text{NO}_x$ .

64. (Original): The method of claim 63 wherein nitrogen of the remote plasma nitrogen is derived entirely from  $\text{NO}_x$ .

65. (Original): The method of claim 44 wherein the (a) feeding comprises  $\text{O}_2$ .

66. (Original): The method of claim 65 wherein the (a) feeding consists essentially of  $\text{O}_2$ .

67. (Original): The method of claim 44 wherein the (a) feeding comprises  $\text{O}_3$ .



68. (Currently Amended): An atomic layer deposition method of depositing an oxide on a substrate comprising:

positioning providing a substrate within a deposition chamber;

chemisorbing a first species to form a first species monolayer onto the substrate within the deposition chamber from a gaseous trimethyl aluminum comprising precursor;

feeding a) at least one of  $O_2$  and  $O_3$ , and b) nitrogen to a remote plasma generator and forming a mixture of remote plasma oxygen and remote plasma nitrogen therefrom, the mixture comprising the remote plasma nitrogen at from 0.1% to 10% by volume of all remote plasma oxygen and remote plasma nitrogen generated by the generator;

feeding the remote plasma mixture to the deposition chamber and to contact the chemisorbed first species effective to react with the first species to form a monolayer comprising aluminum oxide; and

successively repeating the chemisorbing and the contacting with remote plasma oxygen and with remote plasma nitrogen effective to form porous aluminum oxide on the substrate.

69. (Original): The method of claim 68 wherein the (a) feeding comprises  $O_2$ .

70. (Original): The method of claim 69 wherein the (a) feeding consists essentially of  $O_2$ .

71. (Original): The method of claim 68 wherein the (a) feeding comprises O<sub>3</sub>.

72. (Original): The method of claim 68 wherein the mixture comprises the remote plasma nitrogen at from 0.1% to 3% by volume of all remote plasma oxygen and remote plasma nitrogen fed to the deposition chamber.

73. (Original): The method of claim 68 wherein the mixture comprises the remote plasma nitrogen at from 0.01% to 1% by volume of all remote plasma oxygen and remote plasma nitrogen fed to the deposition chamber.

74. (Original): The method of claim 68 wherein the remote plasma nitrogen is derived at least in part from N<sub>2</sub>.

75. (Original): The method of claim 74 wherein nitrogen of the remote plasma nitrogen is derived entirely from N<sub>2</sub>.

76. (Original): The method of claim 68 wherein the remote plasma nitrogen is derived at least in part from N<sub>2</sub>O.

77. (Original): The method of claim 76 wherein nitrogen of the remote plasma nitrogen is derived entirely from N<sub>2</sub>O.

78. (Original): The method of claim 68 wherein the remote plasma nitrogen is derived at least in part from  $\text{NO}_x$ .

79. (Original): The method of claim 78 wherein nitrogen of the remote plasma nitrogen is derived entirely from  $\text{NO}_x$ .

80. (New): The method of claim 1 wherein successively repeating the chemisorbing and the contacting with remote plasma oxygen and with remote plasma nitrogen forms the porous oxide to be void of nitrogen.

81. (New): The method of claim 44 wherein successively repeating the chemisorbing and the contacting with remote plasma oxygen and with remote plasma nitrogen forms the porous oxide to be void of nitrogen.

82. (New): The method of claim 68 wherein successively repeating the chemisorbing and the contacting with remote plasma oxygen and with remote plasma nitrogen forms the porous aluminum oxide to be void of nitrogen.